

Notice of References Cited

Application/Control No.

10/725,773

Applicant(s)/Patent Under
Reexamination
LEE ET AL.

Examiner

Ryan R. Yang

Art Unit

2628

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,861,889	01-1999	Wallace et al.	345/619
*	B	US-5,588,098	12-1996	Chen et al.	345/653
*	C	US-6,720,987	04-2004	Koyanagi et al.	348/36
*	D	US-5,745,126	04-1998	Jain et al.	382/154
*	E	US-6,028,645	02-2000	Reid et al.	348/578
*	F	US-6,215,494	04-2001	Teo, Patrick Cheng-San	345/418
*	G	US-5,293,313	03-1994	Cecil et al.	382/131
*	H	US-6,496,183	12-2002	Bar-Nahum, Guy	345/419
*	I	US-5,461,709	10-1995	Brown, Robert J.	715/848
*	J	US-6,710,783	03-2004	Noetting, Alois	345/650
*	K	US-5,838,906	11-1998	Doyle et al.	715/205
*	L	US-6,674,461	01-2004	Klapman, Matthew H.	348/42
*	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.